

Notice of References Cited	Application/Control No. 10/594,555		Applicant(s)/Patent Under Reexamination FUKUI ET AL.	
	Examiner ANKUR JAIN		Art Unit 2618	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0068588 A1	06-2002	Yoshida et al.	455/461
*	B	US-6,633,541	10-2003	Hijikata et al.	370/231
*	C	US-2003/0162531 A1	08-2003	Yahiro, Chihoko	455/414
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	L	US-			
	M	US-			

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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